



# IRFP450/451/452/453 IRFP450R/451R/452R/453R

N-Channel Power MOSFETs  
Avalanche Energy Rated\*

August 1991

### Features

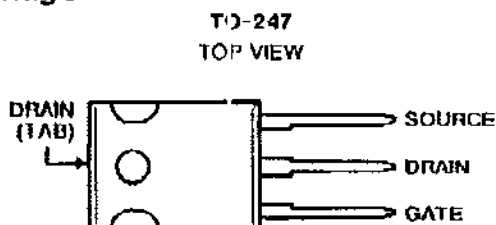
- 12A and 14A, 450V - 500V
- $r_{DS(on)} = 0.4\Omega$  and  $0.5\Omega$
- Single Pulse Avalanche Energy Rated\*
- SOA Is Power-Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance

### Description

The IRFP450, IRFP451, IRFP452, and IRFP453 are n-channel enhancement-mode silicon-gate power field-effect transistors. IRFP450R, IRFP451R, IRFP452R and IRFP453R types are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high-power bipolar switching transistors requiring high speed and low gate-drive power. These types can be operated directly from integrated circuits.

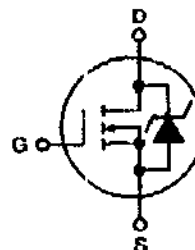
The IRFP types are supplied in the JEDEC TO-247 plastic package.

### Package



### Terminal Diagram

N-CHANNEL ENHANCEMENT MODE



### Absolute Maximum Ratings ( $T_C = +25^\circ\text{C}$ ), Unless Otherwise Specified

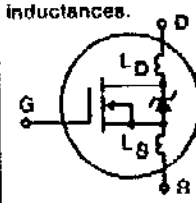
|   | IRFP450<br>IRFP450R        | IRFP451<br>IRFP451R | IRFP452<br>IRFP452R | IRFP453<br>IRFP453R | UNITS               |
|---|----------------------------|---------------------|---------------------|---------------------|---------------------|
| Drain-Source Voltage (1) .....                        | $V_{DS}$ 500               | 450                 | 500                 | 450                 | V                   |
| Drain-Gate Voltage ( $R_{GS} = 20k\Omega$ ) (1) ..... | $V_{DGR}$ 500              | 450                 | 500                 | 450                 | V                   |
| Continuous Drain Current                              |                            |                     |                     |                     |                     |
| $T_C = +25^\circ\text{C}$ .....                       | $I_D$ 14                   | 14                  | 12                  | 12                  | A                   |
| $T_C = +100^\circ\text{C}$ .....                      | $I_D$ 8.8                  | 8.8                 | 7.9                 | 7.9                 | A                   |
| Pulsed Drain Current (3) .....                        | $I_{DM}$ 56                | 56                  | 48                  | 48                  | A                   |
| Gate-Source Voltage .....                             | $V_{GS}$ $\pm 20$          | $\pm 20$            | $\pm 20$            | $\pm 20$            | V                   |
| Maximum Power Dissipation                             |                            |                     |                     |                     |                     |
| $T_C = +25^\circ\text{C}$ .....                       | $P_D$ 180                  | 180                 | 180                 | 180                 | W                   |
| Linear Derating Factor .....                          | 1.44                       | 1.44                | 1.44                | 1.44                | W/ $^\circ\text{C}$ |
| Inductive Current, Clamped .....                      | $I_{LM}$ 52                | 52                  | 48                  | 48                  | A                   |
| (See Figure 14, $L = 100\mu\text{H}$ )                |                            |                     |                     |                     |                     |
| Single Pulse Avalanche Energy Rating (4) .....        | $E_{AS}^*$ 860             | 860                 | 860                 | 860                 | mJ                  |
| Operating and Storage Junction .....                  | $T_J, T_{STG}$ -55 to +150 | -55 to +150         | -55 to +150         | -55 to +150         | $^\circ\text{C}$    |
| Temperature Range                                     |                            |                     |                     |                     |                     |
| Maximum Lead Temperature for Soldering .....          | $T_L$ 300                  | 300                 | 300                 | 300                 | $^\circ\text{C}$    |
| (0.063" (1.6mm) from case for 10s)                    |                            |                     |                     |                     |                     |

NOTES:

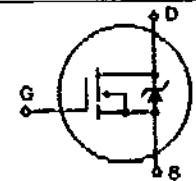
1.  $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$ .
  2. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
  3. Repetitive rating: Pulse width limited by maximum junction temperature. See Transient Thermal Impedance Curve (Figure 5).
  4.  $V_{DD} = 50\text{V}$ , starting  $T_J = +25^\circ\text{C}$ ,  $L = 7.9\text{mH}$ ,  $R_{GS} = 25\Omega$ ,  $I_{PEAK} = 14\text{A}$ . See Figure 15.
- \*R Suffix Types Only

# IRFP450, IRFP451, IRFP452, IRFP453 IRFP450R, IRFP451R, IRFP452R, IRFP453R

Electrical Characteristics  $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

| CHARACTERISTIC   | SYMBOL          | TEST CONDITIONS   | LIMITS  |      |      | UNITS              |    |
|--|-----------------|---|---|------|------|--------------------|----|
|  |                 |   | MIN   | TYP  | MAX  |                    |    |
| Drain-Source Breakdown Voltage<br>IRFP450/452, IRFP450R/452R<br>IRFP451/453, IRFP451R/453R                   | $BV_{DSS}$      | $V_{GS} = 0V, I_D = 250\mu A$   | 500   | -    | -    | V                  |    |
|  |                 |   | 450   | -    | -    | V                  |    |
| Gate Threshold Voltage   | $V_{GS(TH)}$    | $V_{DS} = V_{GS}, I_D = 250\mu A$   | 2.0   | -    | 4.0  | V                  |    |
| Gate-Source Leakage Forward  | $I_{GSS}$       | $V_{GS} = 20V$  | -   | -    | 500  | nA                 |    |
| Gate-Source Leakage Reverse  | $I_{GSS}$       | $V_{GS} = -20V$   | -   | -    | -500 | nA                 |    |
| Zero Gate Voltage-Drain Current  | $I_{DSS}$       | $V_{DS} = \text{Max Rating}, V_{GS} = 0V$   | -   | -    | 250  | $\mu A$            |    |
|  |                 | $V_{DS} = \text{Max Rating} \times 0.8, V_{GS} = 0V, T_J = +125^\circ\text{C}$  | -   | -    | 1000 | $\mu A$            |    |
| On-State Drain Current (Note 2)<br>IRFP450/451, IRFP450R/451R<br>IRFP452/453, IRFP452R/453R                  | $I_{D(ON)}$     | $V_{DS} > I_{D(ON)} \times r_{DS(ON)} \text{ Max}, V_{GS} = 10V$  | 14  | -    | -    | A                  |    |
|  |                 |   | 12  | -    | -    | A                  |    |
| Static Drain-Source On-State Resistance (Note 2)<br>IRFP450/451, IRFP450R/451R<br>IRFP452/453, IRFP452R/453R | $r_{DS(ON)}$    | $V_{GS} = 10V, I_D = 7.9A$  | -   | 0.3  | 0.4  | $\Omega$           |    |
|  |                 |   | -   | 0.4  | 0.5  | $\Omega$           |    |
| Forward Transconductance (Note 2)  | $g_{fs}$        | $V_{DS} \geq 50V, I_D = 7.9A$   | 3.3   | 13.8 | -    | S(V)               |    |
| Input Capacitance  | $C_{ISS}$       | $V_{GS} = 0V, V_{DS} = 25V, f = 1.0\text{MHz}$<br>See Figure 10   | -   | 2000 | -    | pF                 |    |
| Output Capacitance   | $C_{OSS}$       |   | -   | 400  | -    | pF                 |    |
| Reverse Transfer Capacitance   | $C_{RSS}$       |   | -   | 100  | -    | pF                 |    |
| Turn-On Delay Time   | $t_{d(ON)}$     |   | $V_{DD} = 250V, I_D = 14A, R_G = 6.1\Omega$<br>See Figure 16. (MOSFET switching times are essentially independent of operating temperature) | -    | 16   | 27                 | ns |
| Rise Time  | $t_r$           |   | -   | 45   | 66   | ns                 |    |
| Turn-Off Delay Time  | $t_{d(OFF)}$    |   | -   | 68   | 100  | ns                 |    |
| Fall Time  | $t_f$           |   | -   | 41   | 60   | ns                 |    |
| Total Gate Charge (Gate-Source + Gate-Drain)   | $Q_g$           | $V_{GS} = 10V, I_D = 14A, V_{DS} = 0.8V \text{ Max}$<br>Rating. See Figure 17 for test circuit.<br>(Gate charge is essentially independent of operating temperature.) | -   | 82   | 130  | nC                 |    |
| Gate-Source Charge   | $Q_{gs}$        |   | -   | 12   | -    | nC                 |    |
| Gate-Drain ("Miller") Charge   | $Q_{gd}$        |   | -   | 42   | -    | nC                 |    |
| Internal Drain Inductance  | $L_D$           | Measured between the contact screw on header that is closer to source and gate pins and center of center of die.  |   | -    | 5.0  | -                  | nH |
| Internal Source Inductance   | $L_S$           | Measured from the source lead, 6mm (0.25") from header and source bonding pad.  |   | -    | 12.5 | -                  | nH |
| Junction-to-Case   | $R_{\theta JC}$ |   | -   | -    | 0.70 | $^\circ\text{C/W}$ |    |
| Case-to-Sink   | $R_{\theta CS}$ | Mounting surface flat, smooth and greased   | -   | 0.10 | -    | $^\circ\text{C/W}$ |    |
| Junction-to-Ambient  | $R_{\theta JA}$ | Free air operation  | -   | -    | 30   | $^\circ\text{C/W}$ |    |

## Source Drain Diode Ratings and Characteristics

|  |          |  |  |      |     |         |   |
|--|----------|--|--|------|-----|---------|---|
| Continuous Source Current (Body Diode)     | $I_S$    | Modified MOSFET symbol showing the integral reverse P-N junction rectifier.                      |  | -    | -   | 14      | A |
| Pulse Source Current (Body Diode) (Note 3) | $I_{SM}$ |  |  | -    | -   | 56      | A |
| Diode Forward Voltage (Note 2)             | $V_{SD}$ | $T_J = +25^\circ\text{C}, I_S = 14A, V_{GS} = 0V$  | -  | -    | 1.4 | V       |   |
| Reverse Recovery Time                      | $t_{rr}$ | $T_J = +150^\circ\text{C}, I_F = 13A, dI_F/dt = 100A/\mu s$                                      | -  | 1300 | -   | ns      |   |
| Reverse Recovered Charge                   | $Q_{RR}$ | $T_J = +150^\circ\text{C}, I_F = 13A, dI_F/dt = 100A/\mu s$                                      | -  | 7.4  | -   | $\mu C$ |   |
| Forward Turn-on Time                       | $t_{ON}$ | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ . | -  | -    | -   | -       |   |

NOTES: 1.  $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$

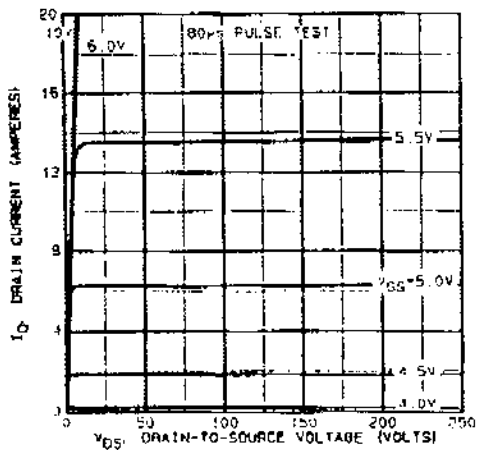
2. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

3. Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Figure 6)

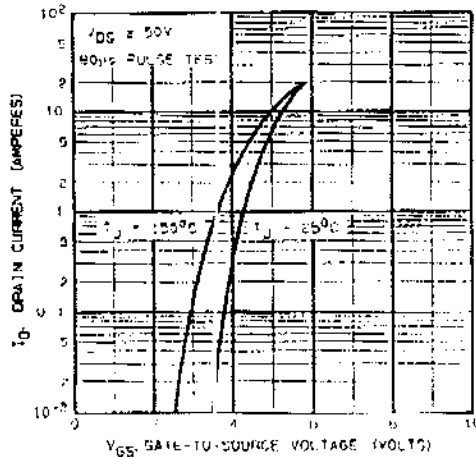
4.  $V_{DI} = 50V$ , Start  $T_J = +25^\circ\text{C}$ ,  $L = 7.8\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{PEAK} = 14A$  (See Figure 15)

**IRFP450, IRFP451, IRFP452, IRFP453 IRFP450R, IRFP451R, IRFP452R, IRFP453R**

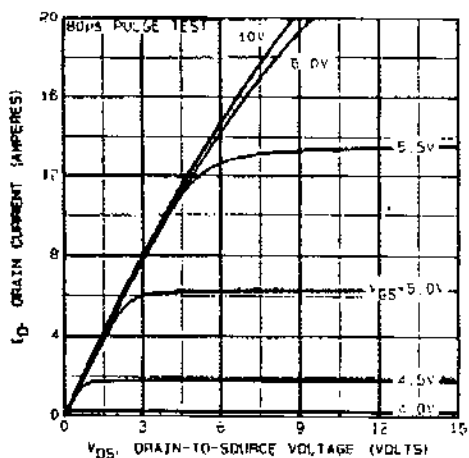
**Performance Curves**



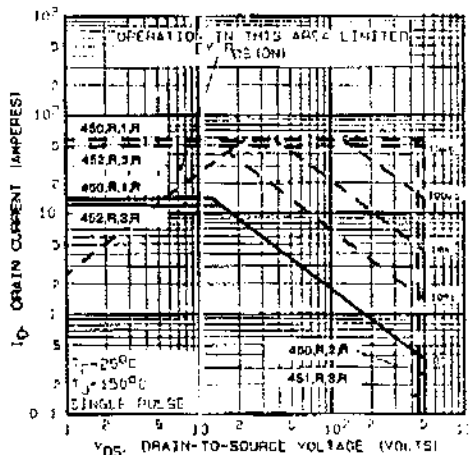
**FIGURE 1. TYPICAL OUTPUT CHARACTERISTICS**



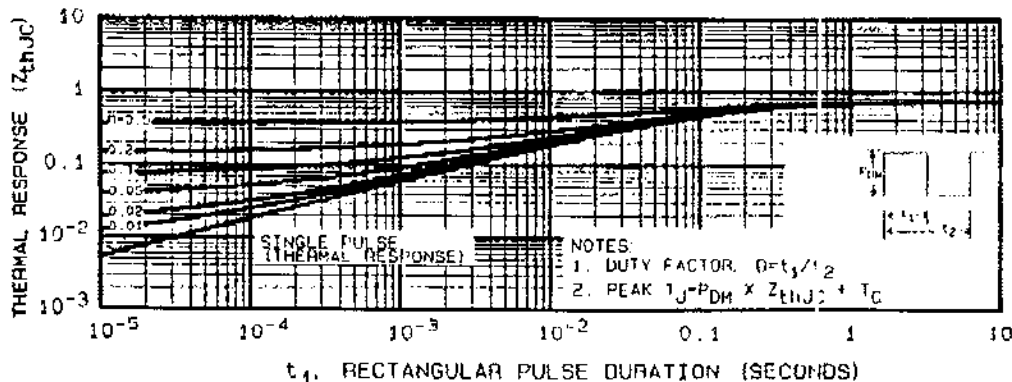
**FIGURE 2. TYPICAL TRANSFER CHARACTERISTICS**



**FIGURE 3. TYPICAL SATURATION CHARACTERISTICS**



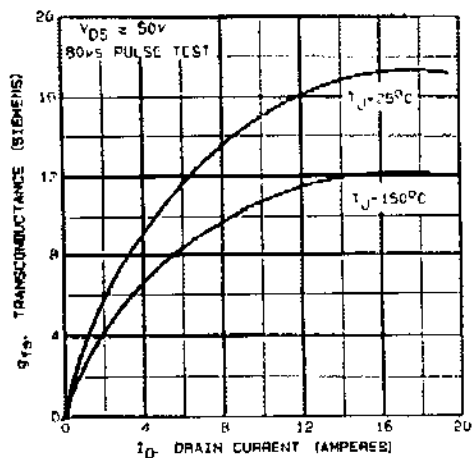
**FIGURE 4. MAXIMUM SAFE OPERATING AREA**



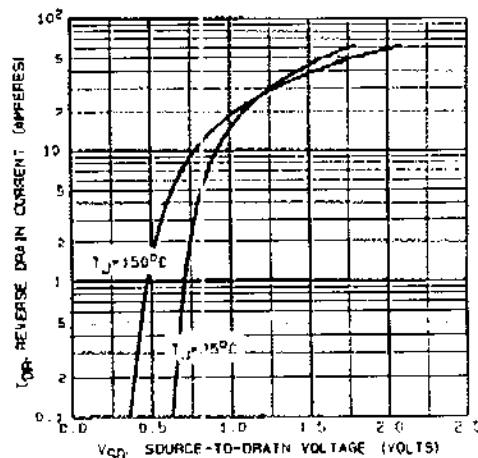
**FIGURE 5. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION**

**IRFP450, IRFP451, IRFP452, IRFP453 IRFP450R, IRFP451R, IRFP452R, IRFP453R**

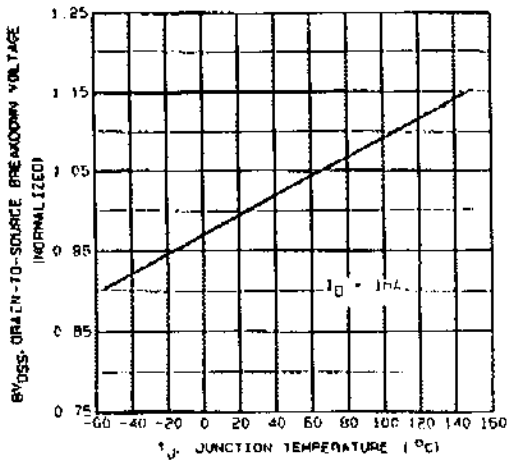
**Performance Curves (Continued)**



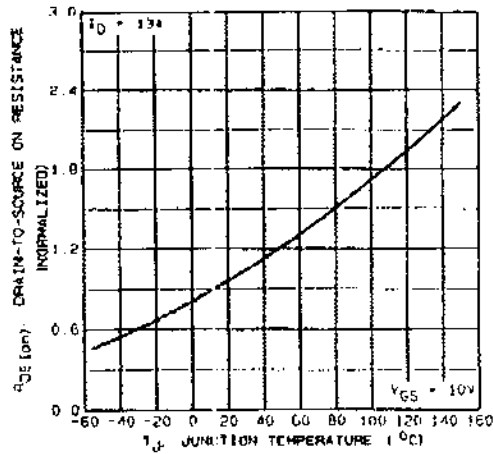
**FIGURE 6. TYPICAL TRANSCONDUCTANCE vs DRAIN CURRENT**



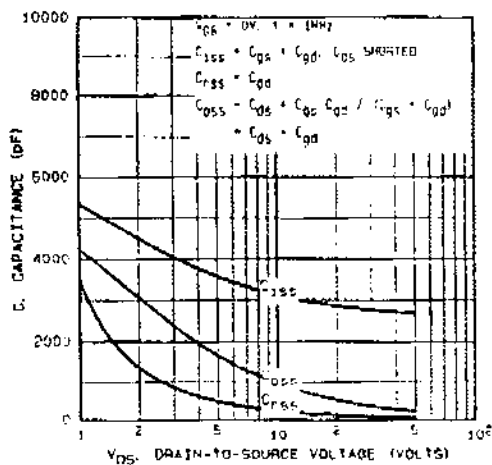
**FIGURE 7. TYPICAL SOURCE-DRAIN DIODE FORWARD VOLTAGE**



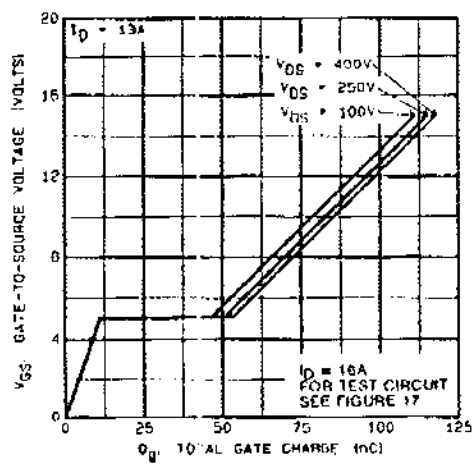
**FIGURE 8. BREAKDOWN VOLTAGE vs TEMPERATURE**



**FIGURE 9. NORMALIZED ON-RESISTANCE vs TEMPERATURE**



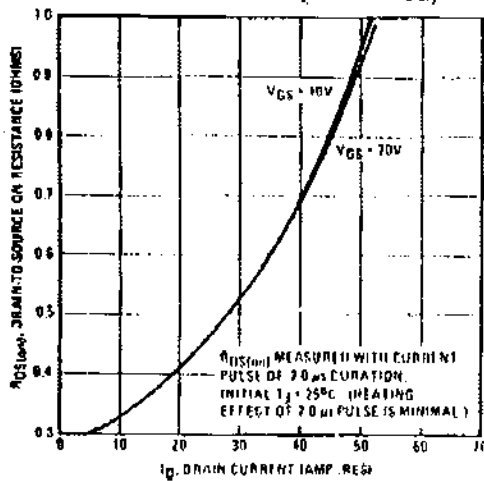
**FIGURE 10. TYPICAL CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE**



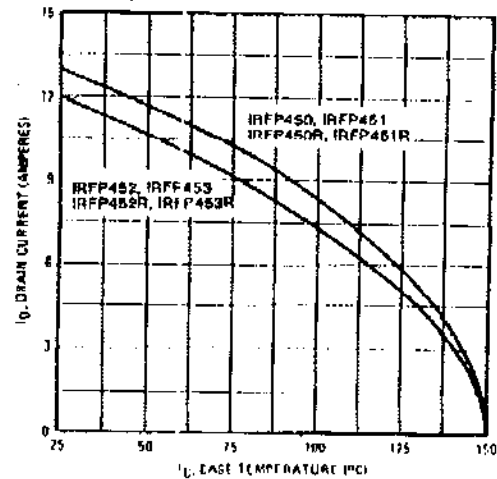
**FIGURE 11. TYPICAL GATE CHARGE vs GATE-TO-SOURCE VOLTAGE**

**IRF450, IRF451, IRF452, IRF453 IRF450R, IRF451R, IRF452R, IRF453R**

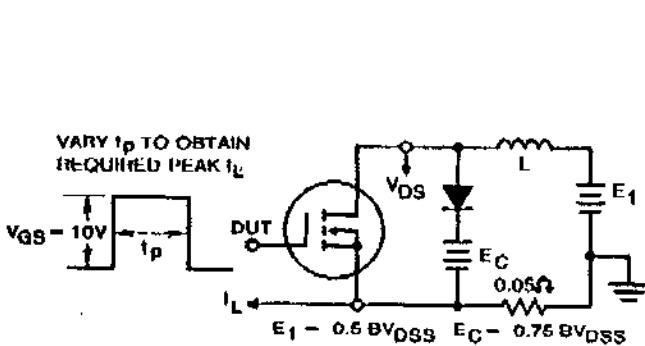
**Performance Curves (Continued)**



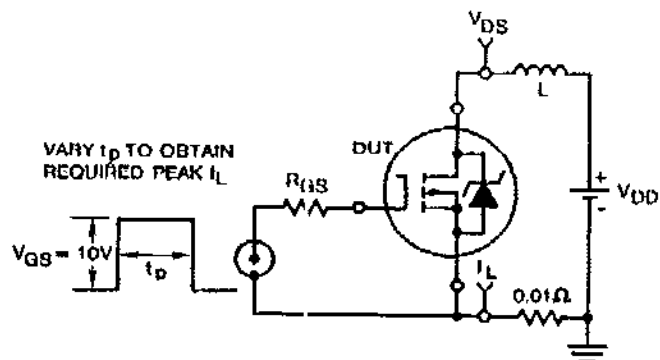
**FIGURE 12. TYPICAL ON-RESISTANCE VS. DRAIN CURRENT**



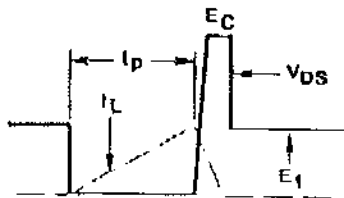
**FIGURE 13. MAXIMUM DRAIN CURRENT VS. CASE TEMPERATURE**



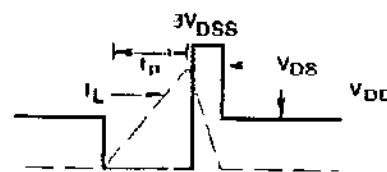
**FIGURE 14a. CLAMPED INDUCTIVE TEST CIRCUIT**



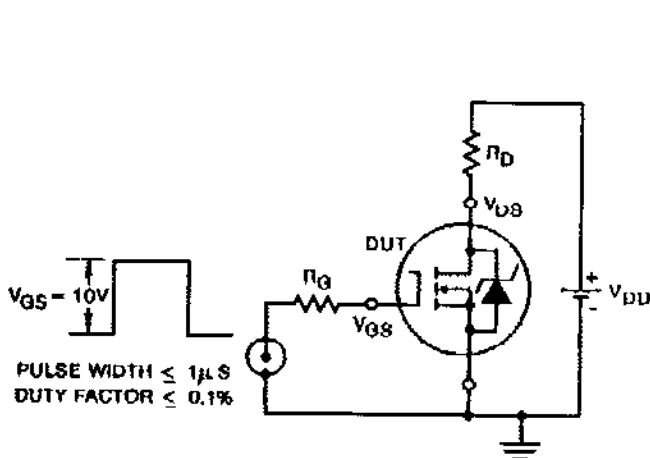
**FIGURE 15a. UNCLAMPED ENERGY TEST CIRCUIT**



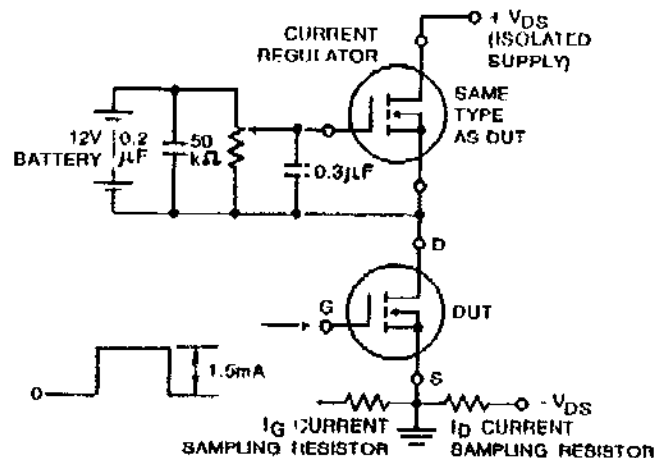
**FIGURE 14b. CLAMPED INDUCTIVE WAVEFORMS**



**FIGURE 15b. UNCLAMPED ENERGY WAVEFORMS**



**FIGURE 16. SWITCHING TIME TEST CIRCUIT**



**FIGURE 17. GATE CHARGE TEST CIRCUIT**